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November 2016

FDMC007N08LC

N-Channel Shielded Gate PowerTrench® MOSFET

80 V, 66 A, 7.0 mΩ

Features

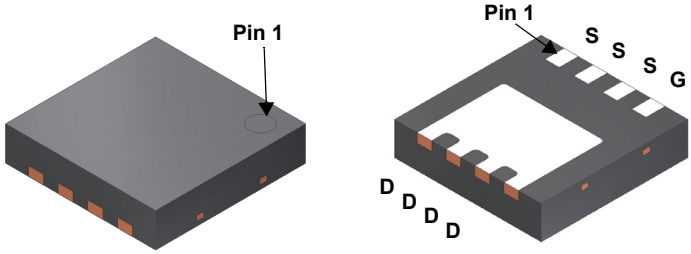
- Shielded Gate MOSFET Technology
- Max $r_{DS(on)}$ = 7.0 mΩ at V_{GS} = 10 V, I_D = 21 A
- Max $r_{DS(on)}$ = 10.4 mΩ at V_{GS} = 4.5 V, I_D = 17 A
- 5V Drive Capable
- 50% lower Qrr than other MOSFET suppliers
- Lowers switching noise/EMI
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

General Description

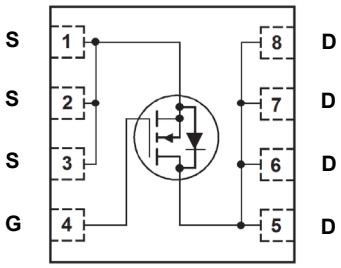
This N-Channel MV MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized to minimise on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar



Top Power 33 Bottom



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			80	V
V_{GS}	Gate to Source Voltage			±20	V
I_D	Drain Current -Continuous	T_C = 25 °C	(Note 5)	66	A
	-Continuous	T_C = 100 °C	(Note 5)	42	
	-Continuous	T_A = 25 °C	(Note 1a)	14	
	-Pulsed		(Note 4)	330	
E_{AS}	Single Pulse Avalanche Energy		(Note 3)	150	mJ
P_D	Power Dissipation	T_C = 25 °C		57	W
	Power Dissipation	T_A = 25 °C	(Note 1a)	2.4	
T_J, T_{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

Package Marking and Ordering Information

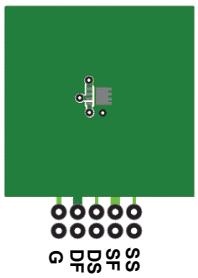
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC007N08L	FDMC007N08LC	Power 33	13 ”	12 mm	3000 units

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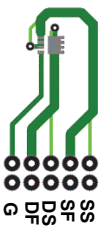
Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		45		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 64 V, V_{GS} = 0 V			1	μA
I_{GSS}	Gate to Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V			100	nA
On Characteristics						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 120 μA	1.0	1.5	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 120 μA, referenced to 25 °C		-5.4		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 21 A		5.7	7.0	mΩ
		V_{GS} = 4.5 V, I_D = 17 A		8.3	10.4	
		V_{GS} = 10 V, I_D = 21 A, T_J = 125 °C		9.9	12.2	
g_{FS}	Forward Transconductance	V_{DS} = 5 V, I_D = 21 A		80		S
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 40 V, V_{GS} = 0 V, f = 1 MHz		2100	2940	pF
C_{oss}	Output Capacitance			506	710	pF
C_{rss}	Reverse Transfer Capacitance			18	30	pF
R_g	Gate Resistance		0.1	0.4	0.8	Ω
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DD} = 40 V, I_D = 21 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		10	20	ns
t_r	Rise Time			2.4	10	ns
$t_{d(off)}$	Turn-Off Delay Time			24	39	ns
t_f	Fall Time			2.1	10	ns
Q_g	Total Gate Charge	V_{GS} = 0 V to 10 V; V_{DD} = 40 V, I_D = 21 A		29	41	nC
Q_g	Total Gate Charge	V_{GS} = 0 V to 4.5 V; V_{DD} = 40 V, I_D = 21 A		14	19	nC
Q_{gs}	Gate to Source Charge	V_{DD} = 40 V, I_D = 21 A		5		nC
Q_{gd}	Gate to Drain “Miller” Charge	V_{DD} = 40 V, I_D = 21 A		3		nC
Q_{oss}	Output Charge	V_{DD} = 40 V, V_{GS} = 0 V		30		nC
Q_{sync}	Total Gate Charge Sync.	V_{DS} = 0 V, I_D = 21 A		27		nC
Drain-Source Diode Characteristics						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 2 A (Note 2)	0.1	0.7	1.2	V
		V_{GS} = 0 V, I_S = 21 A (Note 2)	0.1	0.8	1.3	
t_{rr}	Reverse Recovery Time	I_F = 10 A, di/dt = 300 A/μs		20	32	ns
Q_{rr}	Reverse Recovery Charge			27	43	nC
t_{rr}	Reverse Recovery Time	I_F = 10 A, di/dt = 1000 A/μs		14	22	ns
Q_{rr}	Reverse Recovery Charge			62	99	nC

Notes:
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in^2 pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
3. E_{AS} of 150 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 10 A, V_{DD} = 80 V, V_{GS} = 10 V, 100% test at L = 0.1 mH, I_{AS} = 33 A.
4. Pulsed Id please refer to Fig 11 SOA graph for more details.
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics T_J = 25 °C unless otherwise noted.

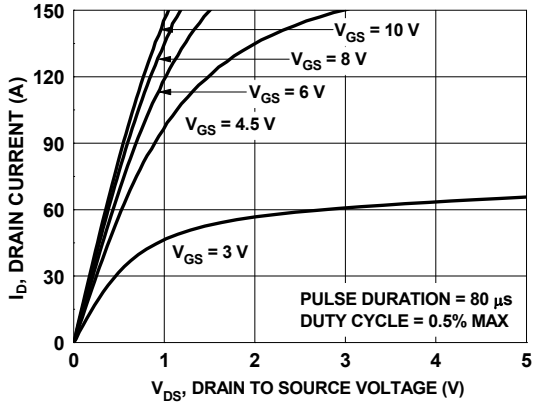


Figure 1. On Region Characteristics

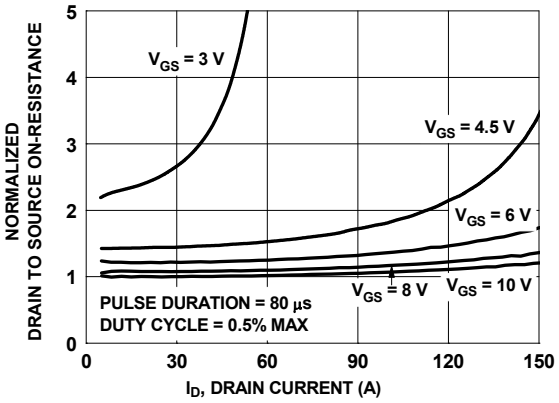


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

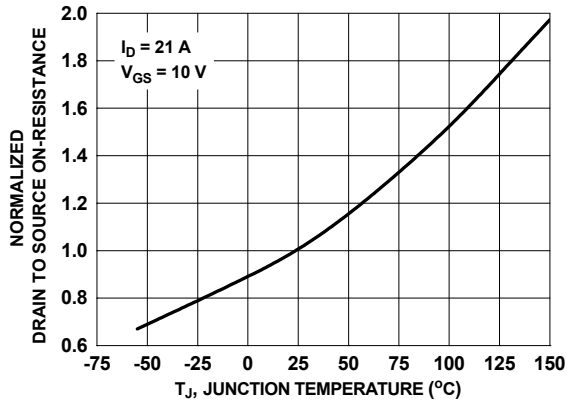


Figure 3. Normalized On Resistance vs. Junction Temperature

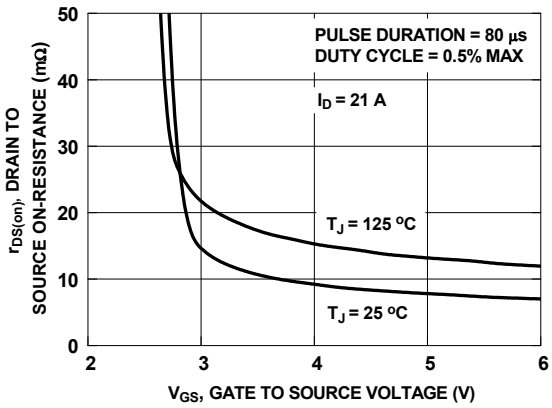


Figure 4. On-Resistance vs. Gate to Source Voltage

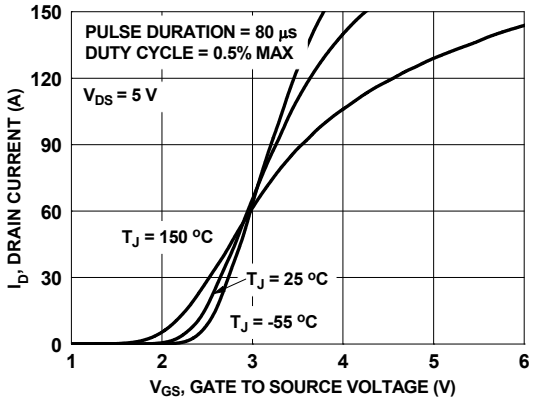


Figure 5. Transfer Characteristics

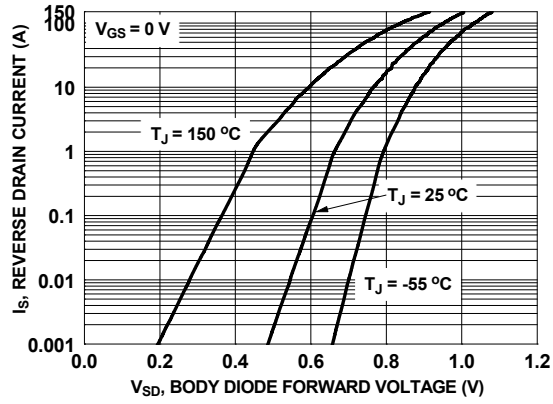


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted.

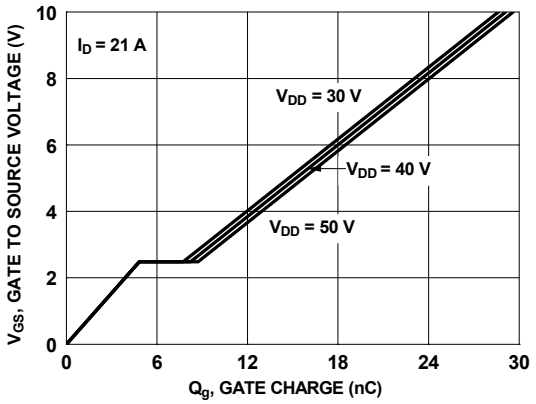


Figure 7. Gate Charge Characteristics

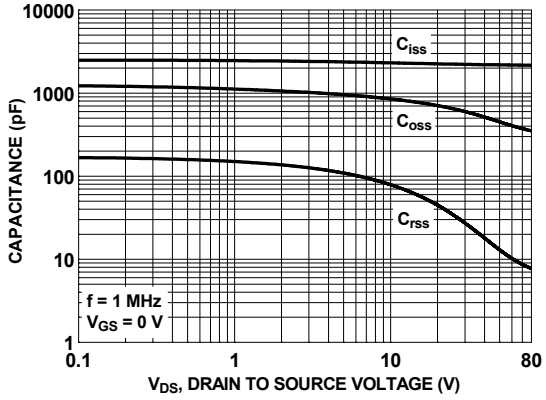


Figure 8. Capacitance vs. Drain to Source Voltage

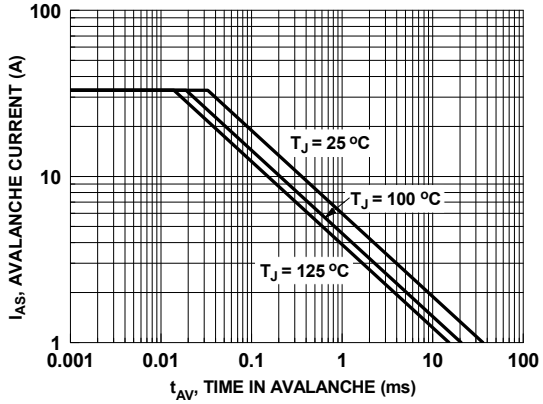


Figure 9. Unclamped Inductive Switching Capability

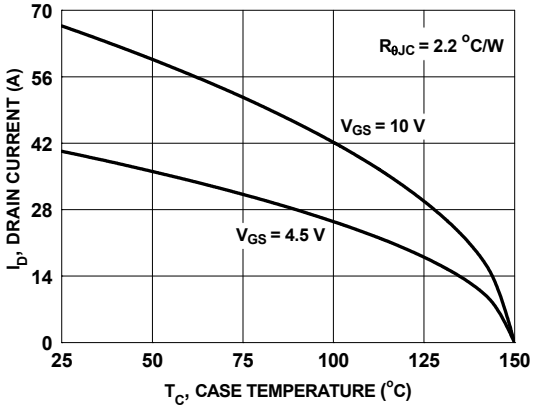


Figure 10. Maximum Continuous Drain Current vs Case Temperature

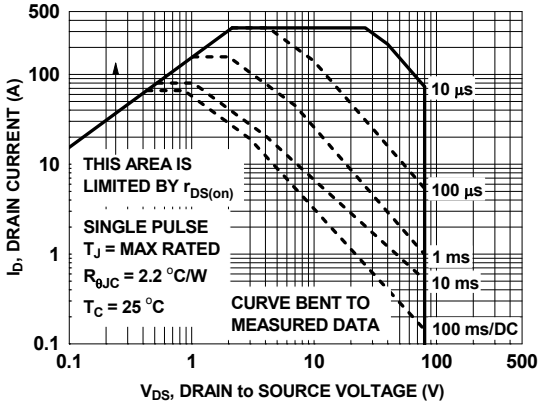


Figure 11. Forward Bias Safe Operating Area

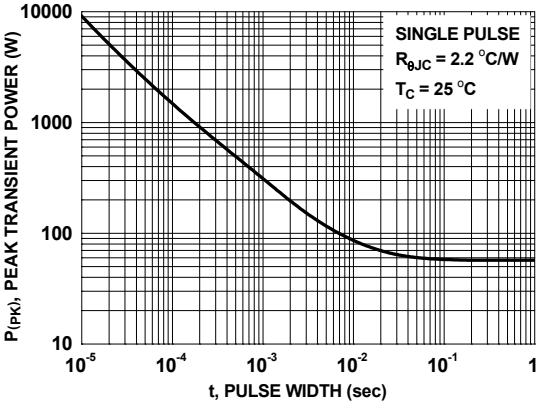


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted.

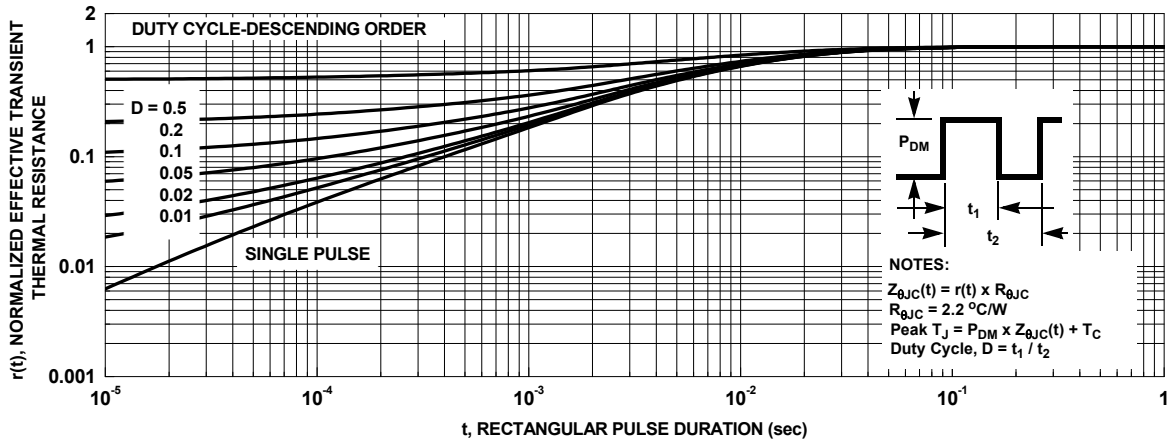
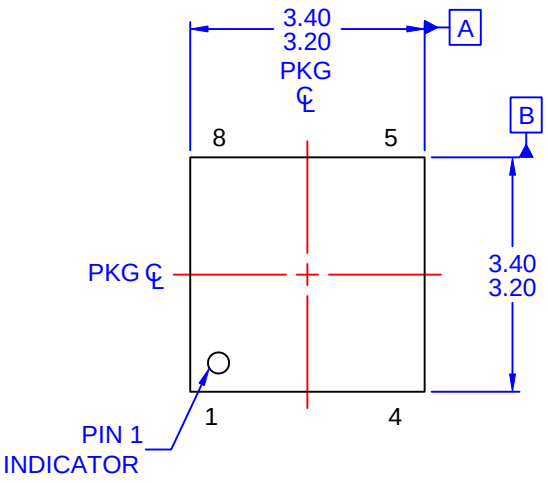
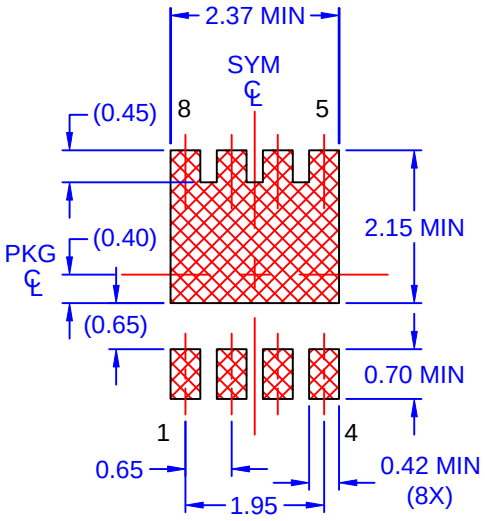
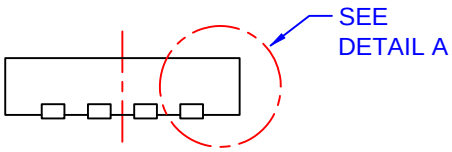


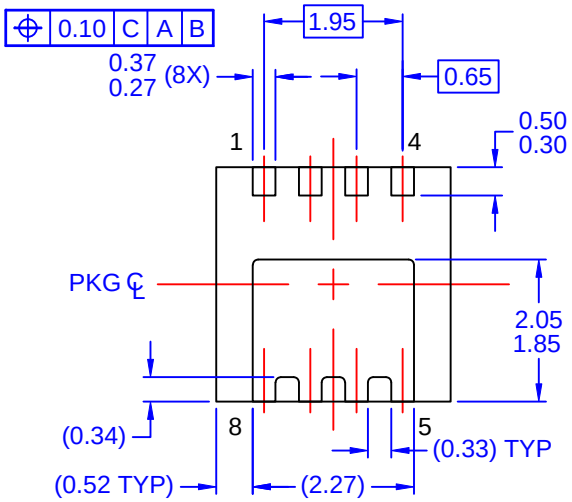
Figure 13. Junction-to-Case Transient Thermal Response Curve





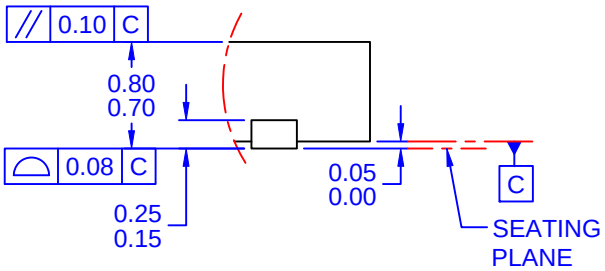
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